



LIST OF RELATED CASES

<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Inventor/Applicant</u>
240733US0*	10/626,612	07/25/03	IKEDA, et al.
240899US-0-PCT	10/470,752	07/31/03	KASHIMA, et al.
228930US0	10/262,317	10/02/02	IKEDA, et al.
198244US0	6,306,527	10/23/01	IKEDA, et al.
00023-1786-0	6,316,127	11/13/01	IKEDA, et al.
00023-1731-0-CONT	6,280,538	08/21/01	SOSHIRODA, et al.
223696US0	10/157,071	05/30/02	UTSUMI, et al.
239964US0	10/614,821	07/09/03	AKAMIZU, et al.

Deborah Kee 2-9-05

*Present Application; listed for information
NFO/amr



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 240733US0	SERIAL NO. 10/626,612		
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shushi IKEDA, et al.			
				FILING DATE July 25, 2003	GROUP 1700		
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
DY	AA	6,306,527	10-23-01	IKEDA et al.			
DY	AB	6,316,127	11-13-01	IKEDA et al.			
O	AC	6,280,538	08-28-01	SOSHIRODA et al.			
	AD						
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	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO				YES	NO	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>Deborah Yee</i>				Date Considered <i>2-9-05</i>			

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified) LIST OF REFERENCES CITED BY APPLICANT		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 240733US0	SERIAL NO. New Application		
		APPLICANT		Shushi IKEDA, et al.			
		FILING DATE		Herewith			GROUP
							1700
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
SY	AO	60-43425	03/08/85	Japan	YES		X
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Deborah Yel</i>		Date Considered 2-9-0					

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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Docket Number	Serial or Patent Number	Filing or Issue Date	Patent Appl. Publication No.	Inventor/ Applicant
258075US0X	10/928,176	08/30/04		KASHIMA, et al.
240733US0*	10/626,612	7/25/03	US 2004-0159373 A1	IKEDA, et al.

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*Present Application; listed for information
NFO/hah/get



LIST OF RELATED CASES

<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Inventor/Applicant</u>
248711US0	10/785,080	02/25/04	IKEDA, et al.
240733US0*	10/626,612	07/25/03	IKEDA, et al.

Debrah Lee 2-9-05

*Present Application; listed for information
NFO/amr/wal